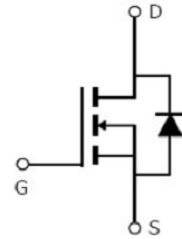


**Main Product Characteristics:**

|              |              |
|--------------|--------------|
| $V_{DS}$     | 100V         |
| $R_{DS(on)}$ | 33mohm(typ.) |
| $I_D$        | 33A ①        |


**TO220**

**Marking and pin Assignment**

**Schematic diagram**
**Features and Benefits:**

- Advanced Process Technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 175°C operating temperature


**Description:**

These N-Channel enhancement mode power field effect transistors are produced using silikron proprietary MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supplies.

**Absolute max Rating:**

| Symbol             | Parameter                                        | Max.        | Units |
|--------------------|--------------------------------------------------|-------------|-------|
| $I_D$ @ TC = 25°C  | Continuous Drain Current, $V_{GS}$ @ 10V         | 33 ①        | A     |
| $I_D$ @ TC = 100°C | Continuous Drain Current, $V_{GS}$ @ 10V         | 23 ①        |       |
| $I_{DM}$           | Pulsed Drain Current ②                           | 132         |       |
| $P_D$ @ TC = 25°C  | Power Dissipation ③                              | 127         | W     |
|                    | Linear Derating Factor                           | 0.85        | W/°C  |
| $V_{DS}$           | Drain-Source Voltage                             | 100         | V     |
| $V_{GS}$           | Gate-to-Source Voltage                           | ± 20        | V     |
| $E_{AS}$           | Single Pulse Avalanche Energy @ L=0.6mH          | 235         | mJ    |
| $I_{AS}$           | Avalanche Current @ L=0.6mH                      | 28          | A     |
| $T_J$ $T_{STG}$    | Operating Junction and Storage Temperature Range | -55 to +175 | °C    |

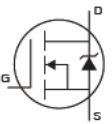
## Thermal Resistance

| Symbol          | Characterizes                                     | Typ. | Max. | Units |
|-----------------|---------------------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-case ③                                | —    | 1.18 | °C/W  |
| $R_{\theta JA}$ | Junction-to-ambient ( $t \leq 10s$ ) ④            | —    | 62   | °C/W  |
|                 | Junction-to-Ambient (PCB mounted, steady-state) ④ | —    | 40   | °C/W  |

## Electrical Characterizes @ $T_A=25^\circ\text{C}$ unless otherwise specified

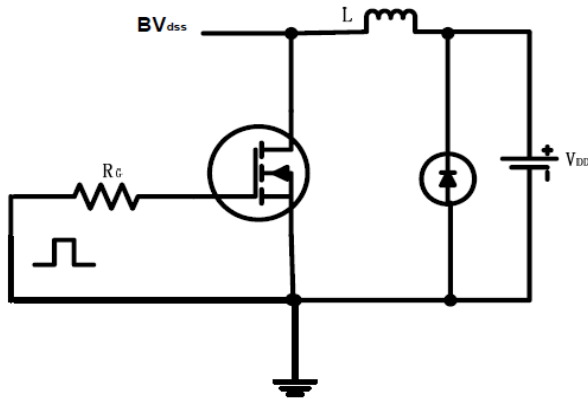
| Symbol        | Parameter                            | Min. | Typ.  | Max. | Units   | Conditions                                                                       |
|---------------|--------------------------------------|------|-------|------|---------|----------------------------------------------------------------------------------|
| $V_{(BR)DSS}$ | Drain-to-Source breakdown voltage    | 100  | —     | —    | V       | $V_{GS} = 0V, I_D = 250\mu A$                                                    |
| $R_{DS(on)}$  | Static Drain-to-Source on-resistance | —    | 33    | 37   | mΩ      | $V_{GS}=10V, I_D=16.5A$                                                          |
|               |                                      | —    | 68.8  | —    |         | $T_J = 125^\circ\text{C}$                                                        |
| $V_{GS(th)}$  | Gate threshold voltage               | 2    | —     | 4    | V       | $V_{DS} = V_{GS}, I_D = 250\mu A$                                                |
|               |                                      | —    | 2.39  | —    |         | $T_J = 125^\circ\text{C}$                                                        |
| $I_{DSS}$     | Drain-to-Source leakage current      | —    | —     | 1    | $\mu A$ | $V_{DS}=100V, V_{GS}=0V$                                                         |
|               |                                      | —    | —     | 50   |         | $T_J = 125^\circ\text{C}$                                                        |
| $I_{GSS}$     | Gate-to-Source forward leakage       | —    | —     | 100  | nA      | $V_{GS}=20V$                                                                     |
|               |                                      | -100 | —     | —    |         | $V_{GS} = -20V$                                                                  |
| $Q_g$         | Total gate charge                    | —    | 26.9  | —    | nC      | $I_D = 33A,$<br>$V_{DS}=80V,$<br>$V_{GS} = 10V$                                  |
| $Q_{gs}$      | Gate-to-Source charge                | —    | 8.2   | —    |         |                                                                                  |
| $Q_{gd}$      | Gate-to-Drain("Miller") charge       | —    | 10.2  | —    |         |                                                                                  |
| $t_{d(on)}$   | Turn-on delay time                   | —    | 29.1  | —    | nS      | $V_{GS}=10V, V_{DD}=50V,$<br>$R_L=1.5\Omega,$<br>$R_{GEN}=25\Omega$<br>$I_D=33A$ |
| $t_r$         | Rise time                            | —    | 133.1 | —    |         |                                                                                  |
| $t_{d(off)}$  | Turn-Off delay time                  | —    | 103.0 | —    |         |                                                                                  |
| $t_f$         | Fall time                            | —    | 89.6  | —    |         |                                                                                  |
| $C_{iss}$     | Input capacitance                    | —    | 1828  | —    | pF      | $V_{GS} = 0V$                                                                    |
| $C_{oss}$     | Output capacitance                   | —    | 182   | —    |         | $V_{DS} = 25V$                                                                   |
| $C_{rss}$     | Reverse transfer capacitance         | —    | 25    | —    |         | $f = 1MHz$                                                                       |

## Source-Drain Ratings and Characteristics

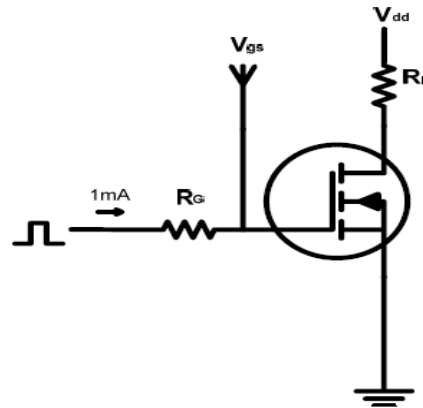
| Symbol   | Parameter                                 | Min. | Typ.  | Max.  | Units | Conditions                                                                                                                                                     |
|----------|-------------------------------------------|------|-------|-------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —    | —     | 33 ①  | A     | MOSFET symb<br>showing the<br>integral reverse<br>p-n junction diode.<br> |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode)     | —    | —     | 132 ① | A     |                                                                                                                                                                |
| $V_{SD}$ | Diode Forward Voltage                     | —    | 0.91  | 1.3   | V     | $I_S=33A, V_{GS}=0V, T_J = 25^\circ\text{C}$                                                                                                                   |
| $t_{rr}$ | Reverse Recovery Time                     | —    | 44.8  | —     | nS    | $T_J = 25^\circ\text{C}, I_F = 33A, di/dt = 100A/\mu s$                                                                                                        |
| $Q_{rr}$ | Reverse Recovery Charge                   | —    | 101.3 | —     | nC    |                                                                                                                                                                |

## Test circuits and Waveforms

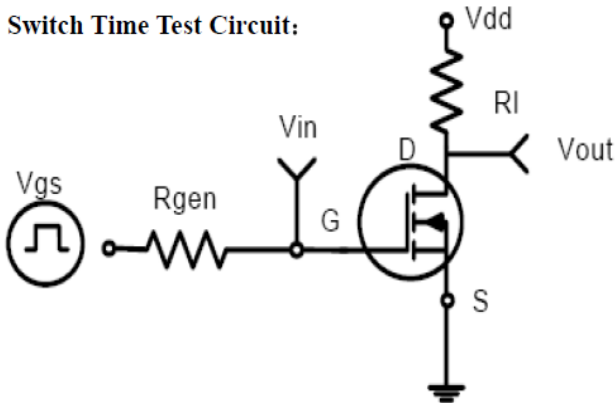
**EAS test circuits:**



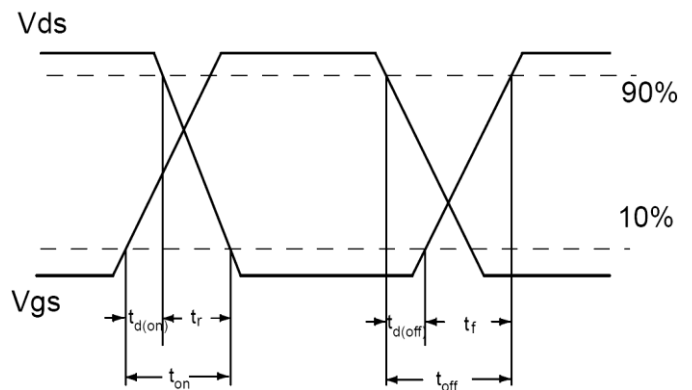
**Gate charge test circuit:**



**Switch Time Test Circuit:**



**Switch Waveforms:**



### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- ④ The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$
- ⑤ These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)} = 175^\circ\text{C}$ .

## Typical electrical and thermal characteristics

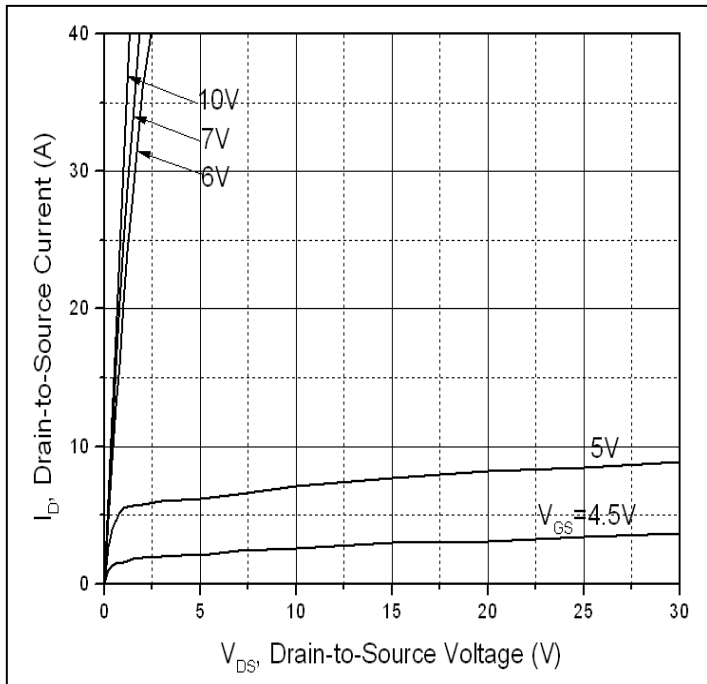


Figure 1: Typical Output Characteristics

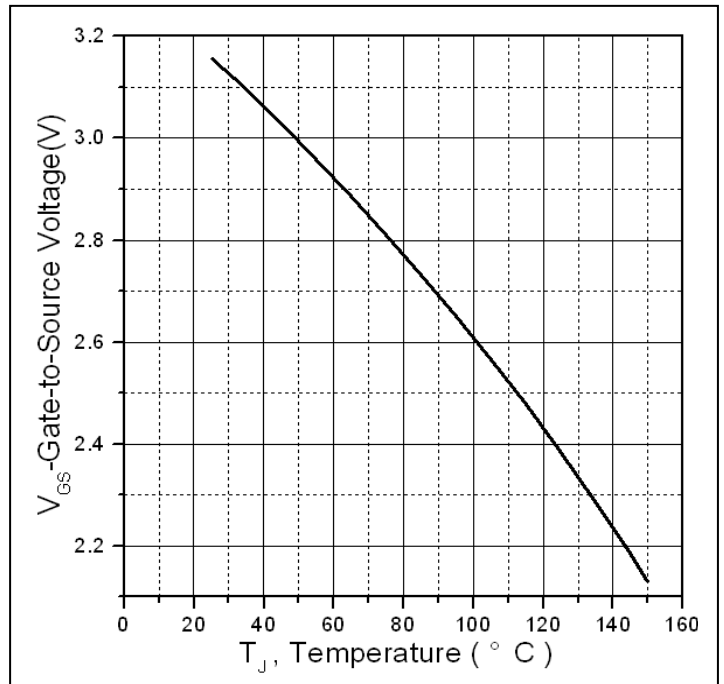


Figure 2. Gate to source cut-off voltage

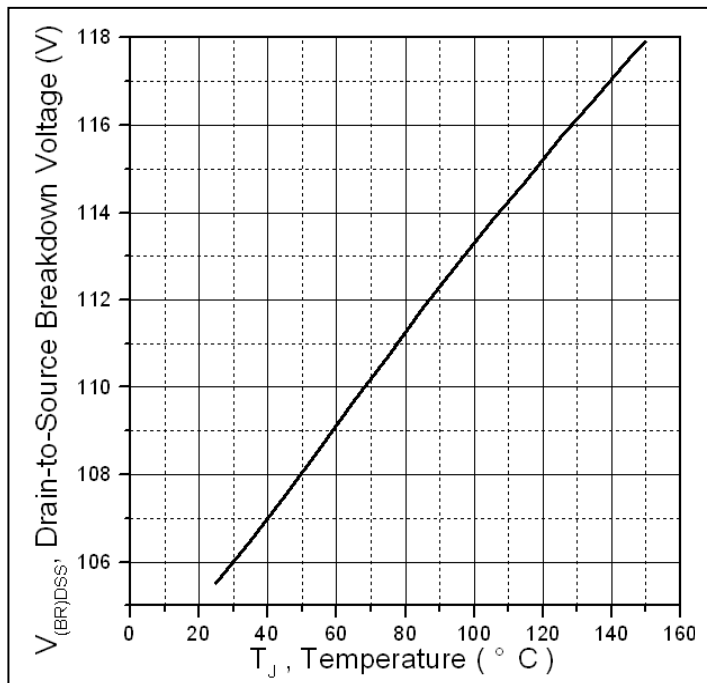


Figure 3. Drain-to-Source Breakdown Voltage vs. Temperature

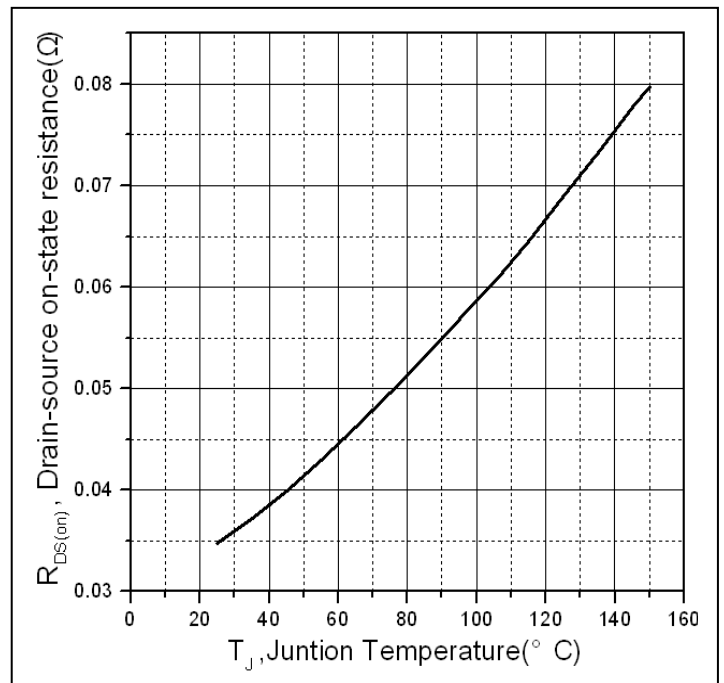


Figure 4: Normalized On-Resistance Vs. Case Temperature

## Typical electrical and thermal characteristics

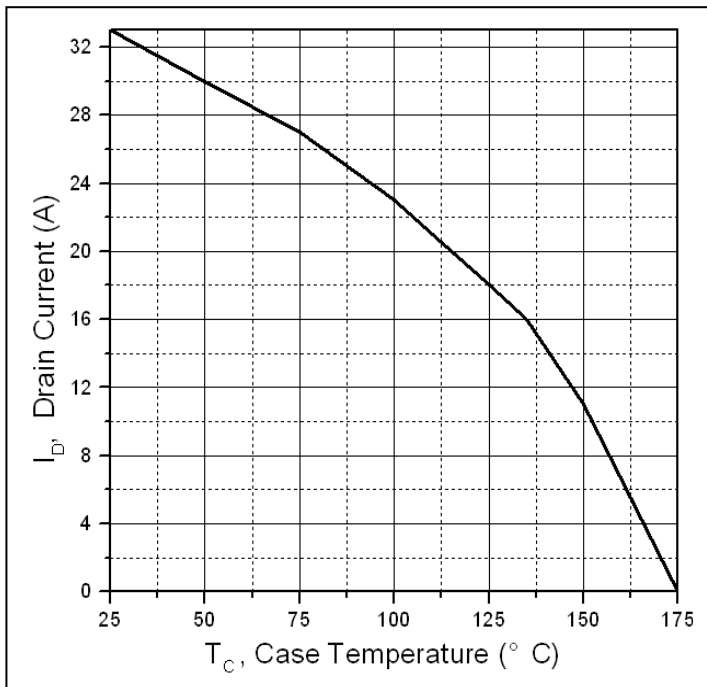


Figure 5. Maximum Drain Current Vs. Case Temperature

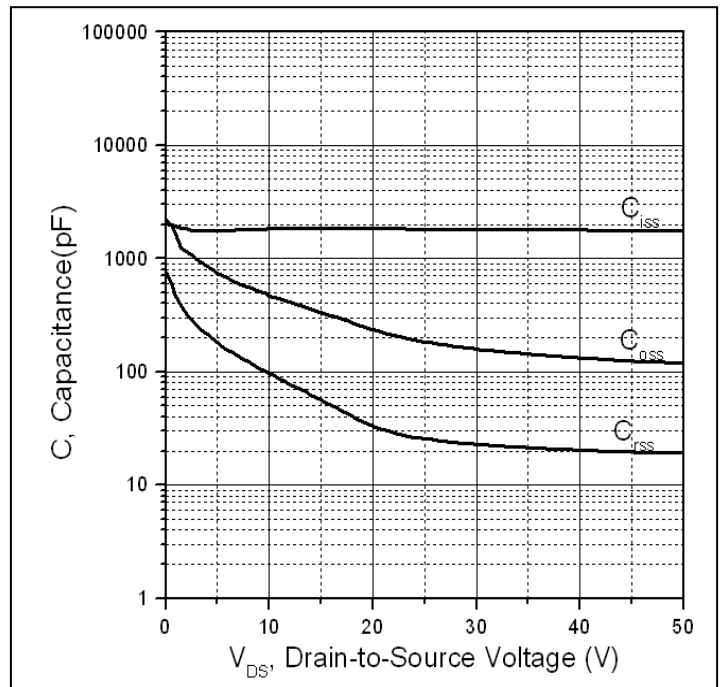


Figure 6. Typical Capacitance Vs. Drain-to-Source Voltage

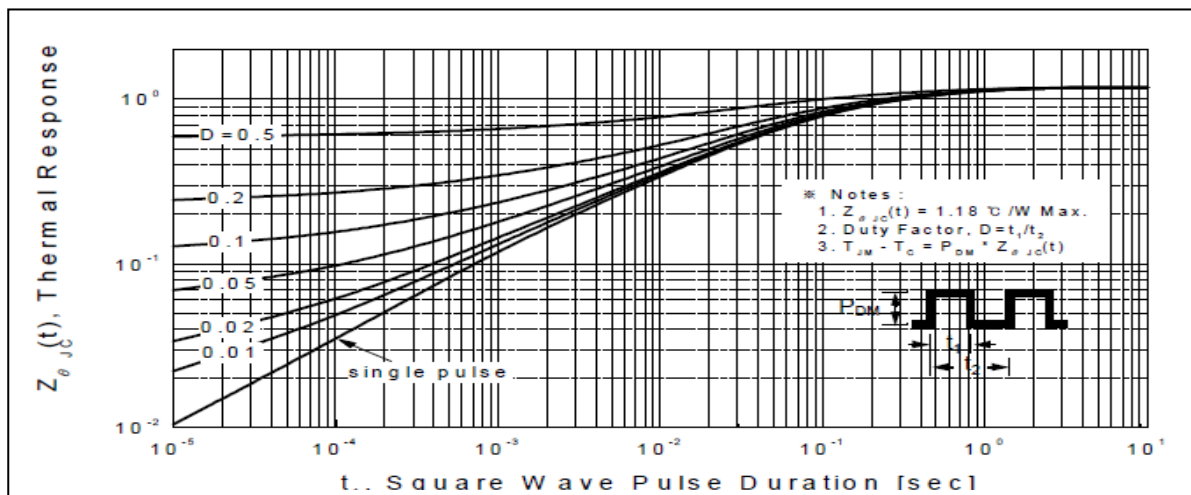
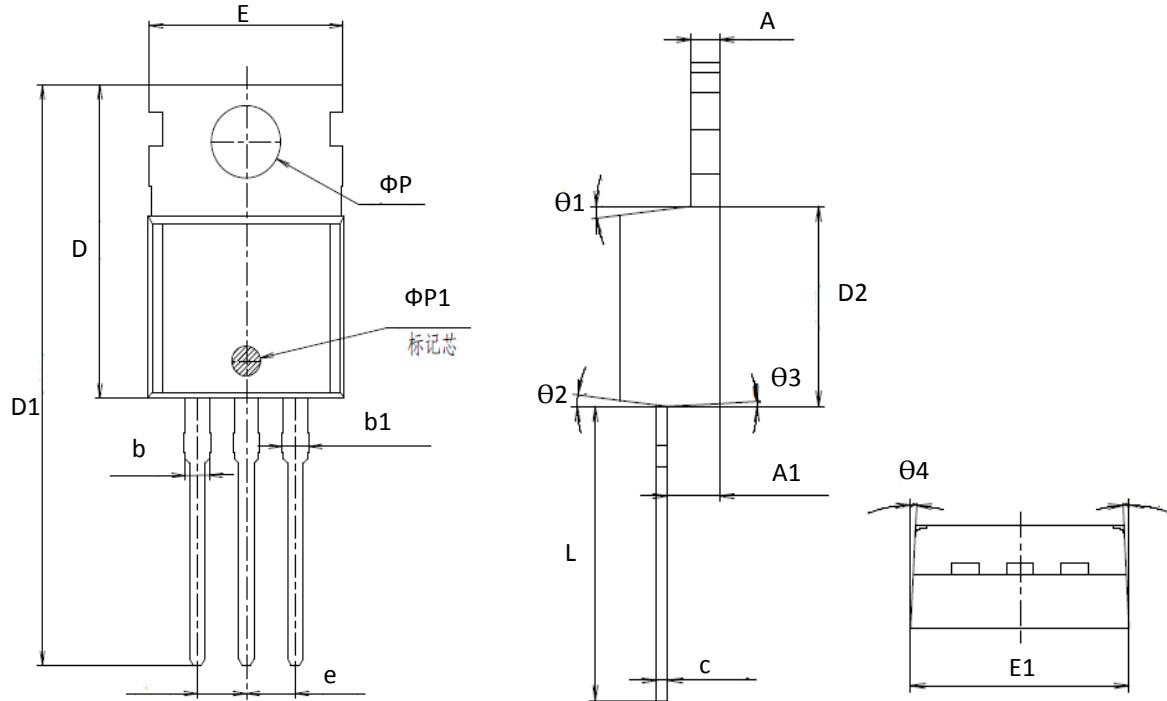


Figure 7. Maximum Effective Transient Thermal Impedance, Junction-to-Case

## Mechanical Data

TO220 PACKAGE OUTLINE DIMENSION\_GN



| Symbol | Dimension In Millimeters |         |        | Dimension In Inches |        |       |
|--------|--------------------------|---------|--------|---------------------|--------|-------|
|        | Min                      | Nom     | Max    | Min                 | Nom    | Max   |
| A      | -                        | 1.300   | -      | -                   | 0.051  | -     |
| A1     | 2.200                    | 2.400   | 2.600  | 0.087               | 0.094  | 0.102 |
| b      | -                        | 1.270   | -      | -                   | 0.050  | -     |
| b1     | 1.270                    | 1.370   | 1.470  | 0.050               | 0.054  | 0.058 |
| c      | -                        | 0.500   | -      | -                   | 0.020  | -     |
| D      | -                        | 15.600  | -      | -                   | 0.614  | -     |
| D1     | -                        | 28.700  | -      | -                   | 1.130  | -     |
| D2     | -                        | 9.150   | -      | -                   | 0.360  | -     |
| E      | 9.900                    | 10.000  | 10.100 | 0.390               | 0.394  | 0.398 |
| E1     | -                        | 10.160  | -      | -                   | 0.400  | -     |
| ΦP     | -                        | 3.600   | -      | -                   | 0.142  | -     |
| ΦP1    |                          | 1.500   |        |                     | 0.059  |       |
| e      |                          | 2.54BSC |        |                     | 0.1BSC |       |
| L      | 12.900                   | 13.100  | 13.300 | 0.508               | 0.516  | 0.524 |
| θ1     | -                        | 7°      | -      | -                   | 7°     | -     |
| θ2     | -                        | 7°      | -      | -                   | 7°     | -     |
| θ3     | -                        | 3°      | -      | 5°                  | 7°     | 9°    |
| θ4     | -                        | 3°      | -      | 1°                  | 3°     | 5°    |

**Ordering and Marking Information****Device Marking: SSPL1042**

Package (Available)  
TO220  
Operating Temperature Range  
C : -55 to175 °C

**Devices per Unit**

| Package Type | Units/ Tube | Tubes/Inner Box | Units/Inner Box | Inner Boxes/Carton Box | Units/Carton Box |
|--------------|-------------|-----------------|-----------------|------------------------|------------------|
| TO220        | 50          | 20              | 1000            | 6                      | 6000             |

**Reliability Test Program**

| Test Item                           | Conditions                                                                                                   | Duration                             | Sample Size         |
|-------------------------------------|--------------------------------------------------------------------------------------------------------------|--------------------------------------|---------------------|
| High Temperature Reverse Bias(HTRB) | $T_j=125^{\circ}\text{C}$ to $175^{\circ}\text{C}$ @ 80% of Max $V_{\text{DSS}}/V_{\text{CES}}/V_{\text{R}}$ | 168 hours<br>500 hours<br>1000 hours | 3 lots x 77 devices |
| High Temperature Gate Bias(HTGB)    | $T_j=125^{\circ}\text{C}$ or $175^{\circ}\text{C}$ @ 100% of Max $V_{\text{GSS}}$                            | 168 hours<br>500 hours<br>1000 hours | 3 lots x 77 devices |

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Sales@silikron.com

**Technical Support:**

Technical@silikron.com

**Suzhou Silikron Semiconductor Corp.**

11A, 428 Xinglong Street, Suzhou Industrial Park, P.R.China

TEL: (86-512) 62560688

FAX: (86-512) 65160705

E-mail: Sales@silikron.com